AUTOMOTIVE GRADE

HEXFET[®] Power MOSFET

-55V

20mΩ

-70A

-42A

1

2015-11-13

Features

Advanced Planar Technology •

infineon

- P-Channel MOSFET
- Low On-Resistance
- 150°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax •
- Lead-Free, RoHS Compliant •
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Bees nort number	Dookogo Tupo	Standard Pack	κ	Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRF4905L	TO-262	Tube	50	AUIRF4905L	
	D ² -Pak	Tube	50	AUIRF4905S	
AUIRF4905S	D -Pak	Tape and Reel Left	800	AUIRF4905STRL	
Absolute Maximum Ratings					

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

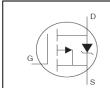
Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	-70	
$I_D @ T_C = 100^{\circ}C$ Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)		-44	•
$I_D @ T_C = 25^{\circ}C$ Continuous Drain Current, $V_{GS} @ 10V$ (Package Limited)		-42	A
I _{DM}	Pulsed Drain Current ①	-280	
P _D @T _C = 25°C	Maximum Power Dissipation	170	W
	Linear Derating Factor	1.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 2		140	
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value 6	790	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	А
E _{AR}	Repetitive Avalanche Energy ①		mJ
TJ	Operating Junction and	-55 to + 150	
T _{STG}	T _{STG} Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

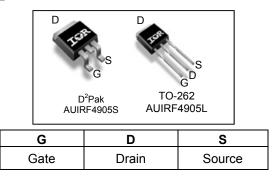
Thermal Resistance

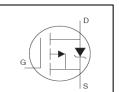
Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case ®		0.75	°C \\
R _{0JA}	Junction-to-Ambient (PCB Mount, steady state) <a>@®		40	°C/W

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*Qualification standards can be found at www.infineon.com







VDSS

R_{DS(on)}

D (Silicon Limited)

D (Package Limited)

max.

AUIRF4905	S
AUIRF4905	



AUIRF4905S/L

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	V _{GS} = 0V, I _D = -250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.054		V/°C	Reference to 25°C, $I_D = -1mA$
R _{DS(on)}	Static Drain-to-Source On-Resistance			20	mΩ	V _{GS} = -10V, I _D = -42A ③
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
gfs	Forward Trans conductance	19			S	V _{DS} = -25V, I _D = -42A
1	Drain-to-Source Leakage Current			-25		V _{DS} = -55V, V _{GS} = 0V
I _{DSS}				-250	μA	V _{DS} = -44V,V _{GS} = 0V,T _J =125°C
I _{GSS}	Gate-to-Source Forward Leakage			-100	$V_{GS} = -20V$	
	Gate-to-Source Reverse Leakage	nA V _{GS} = 20V		V _{GS} = 20V		

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
Diode Cha	aracteristics					
C _{oss eff.}	Effective Output Capacitance		1530			$V_{GS} = 0V, V_{DS} = 0V \text{ to } -44V \oplus$
C _{oss}	Output Capacitance		940		-	$V_{GS} = 0V, V_{DS} = -44V f = 1.0MHz$
C _{oss}	Output Capacitance		4620		рг	$V_{GS} = 0V, V_{DS} = -1.0V f = 1.0MHz$
C _{rss}	Reverse Transfer Capacitance		450		pF	<i>f</i> = 1.0MHz
C _{oss}	Output Capacitance		1250			V _{DS} = -25V
C _{iss}	Input Capacitance		3500			V _{GS} = 0V
Ls	Internal Source Inductance		7.5		nH	from package
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
t _f	Fall Time		64			V _{GS} = -10V ③
t _{d(off)}	Turn-Off Delay Time		51		ns	R _G = 2.6Ω,
t _r	Rise Time		99			I _D = -42A
t _{d(on)}	Turn-On Delay Time		20			$V_{DD} = -28V$
Q_{gd}	Gate-to-Drain Charge		53			V _{GS} = -10V3
Q _{gs}	Gate-to-Source Charge		32		nC	V _{DS} = -44V
Qq	Total Gate Charge		120	180		I _D = -42A

	rarameter		·) P·	max.	Onito	Contaitions
Is	Continuous Source Current (Body Diode)			-42		MOSFET symbol
I _{SM}	Pulsed Source Current (Body Diode) ①			-280		integral reverse p-n junction diode.
V _{SD}	Diode Forward Voltage			-1.3	V	$T_J = 25^{\circ}C, I_S = -42A, V_{GS} = 0V$ (3)
t _{rr}	Reverse Recovery Time		61	92	ns	$T_{J} = 25^{\circ}C$, $I_{F} = -42A$, $V_{DD} = -28V$
Q _{rr}	Reverse Recovery Charge		150	220	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\rm S}\text{+}L_{\rm D})$				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)

Limited by T_{Jmax}, starting T_J = 25°C, L = 0.16mH, R_G = 25Ω, I_{AS} = -42A, V_{GS} =-10V. Part not recommended for use above this value.
Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.

⑤ Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

© This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.08mH, $R_G = 25\Omega$, $I_{AS} = 66A$, $V_{GS} = 10V$.

This is applied to D² Pak, When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



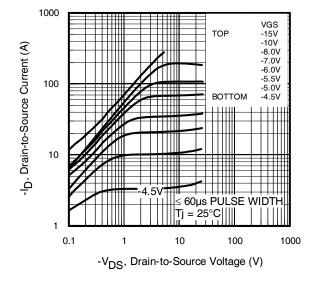


Fig. 1 Typical Output Characteristics

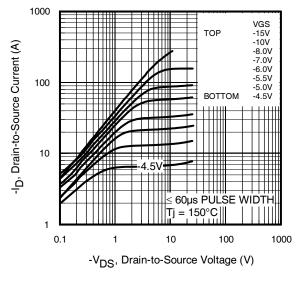


Fig. 2 Typical Output Characteristics

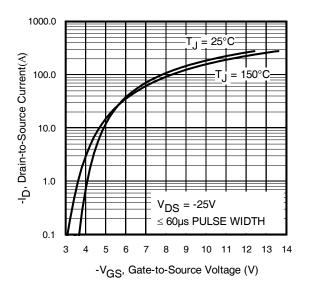


Fig. 3 Typical Transfer Characteristics

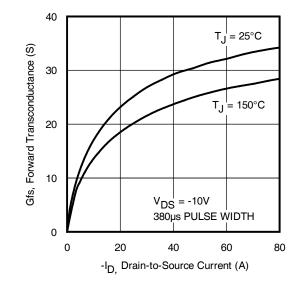


Fig. 4 Typical Forward Trans conductance vs. Drain Current



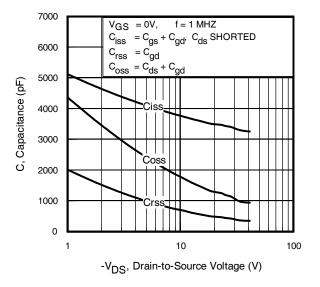


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

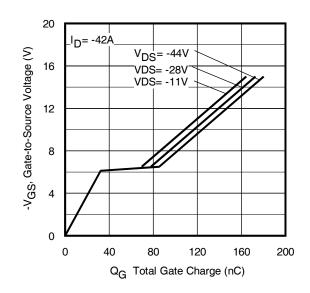


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

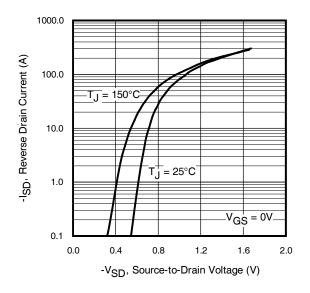


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

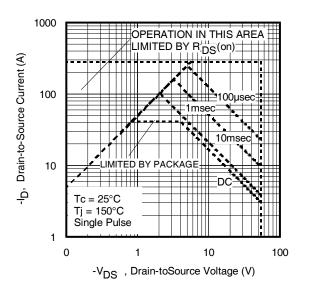


Fig 8. Maximum Safe Operating Area



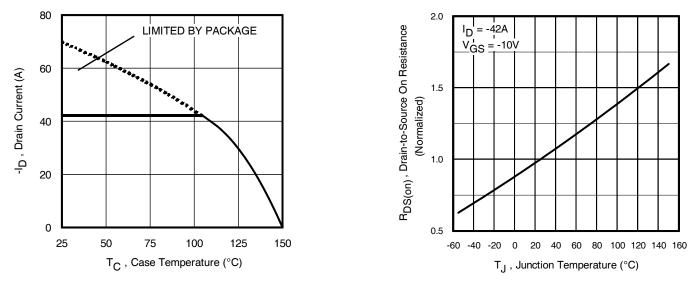
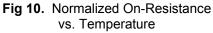


Fig 9. Maximum Drain Current vs. Case Temperature



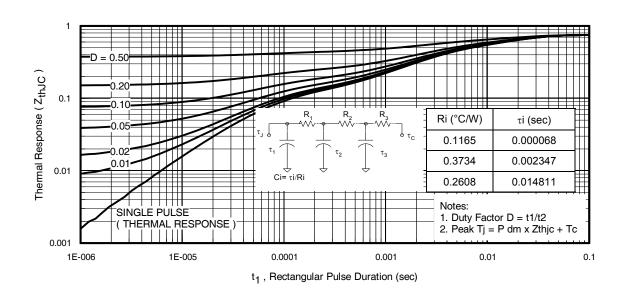


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

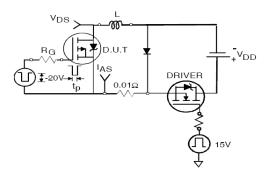
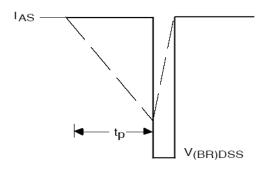


Fig 12a. Unclamped Inductive Test Circuit



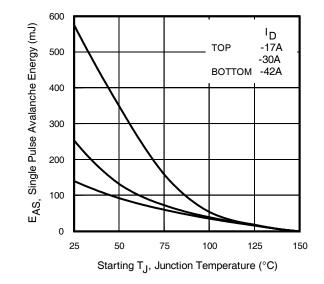


Fig 12b. Unclamped Inductive Waveforms

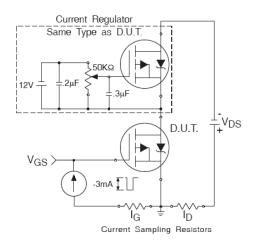


Fig 13a. Gate Charge Test Circuit

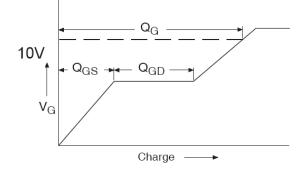


Fig 13b. Gate Charge Waveform

Fig 12c. Maximum Avalanche Energy vs. Drain Current

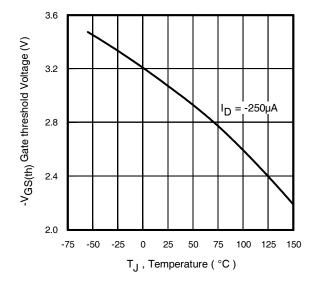


Fig 14. Threshold Voltage vs. Temperature



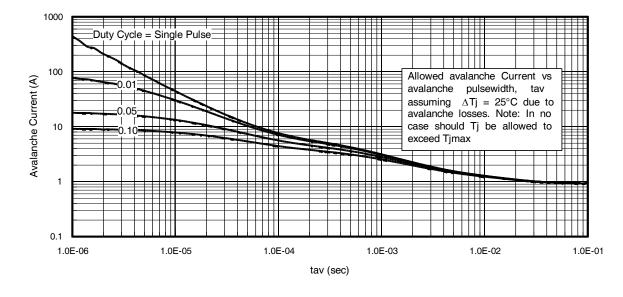


Fig 15. Avalanche Current vs. Pulse width

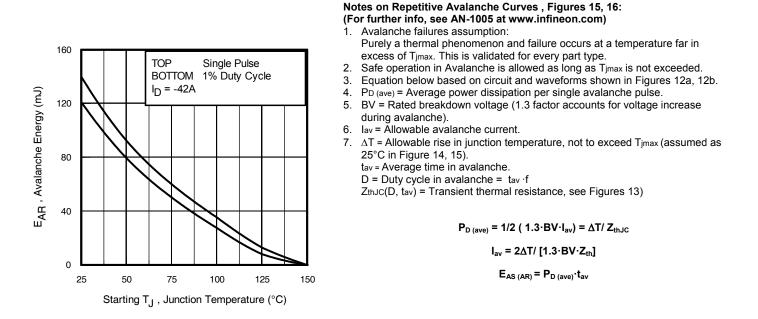


Fig 16. Maximum Avalanche Energy vs. Temperature

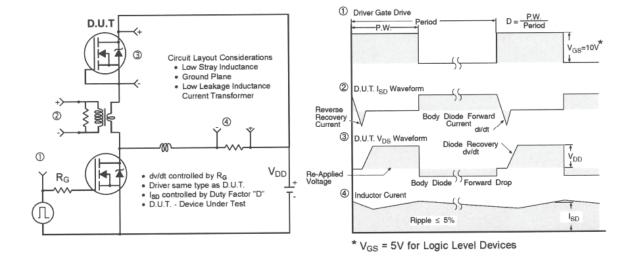
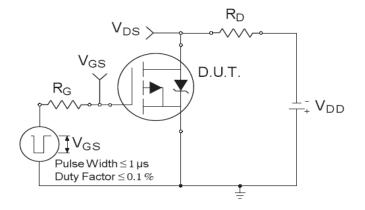
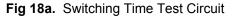


Fig 17. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power MOSFETs





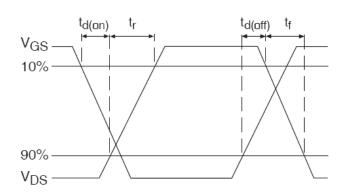
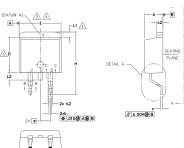


Fig 18b. Switching Time Waveforms

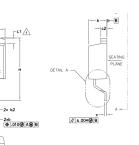


AUIRF4905S/L

D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



AD TIF



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

PLATING BASE WETA
ROTATED 90° CW SCALE 8:1

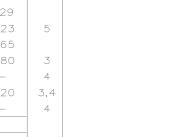
S Y M	DIMENSIONS				
	MILLIM	ETERS	INC	HES	O T E S
B O L	MIN.	MAX.	MIN.	MAX.	L S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	—	4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245	—	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
∟1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25 BSC		.010	BSC	

LEAD ASSIGNMENTS

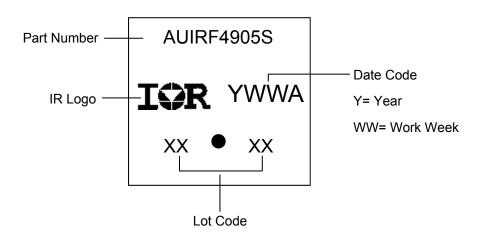
1.- GATE 2, 4.- DRAIN 3.- SOURCE

DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE HEXFET

IGBTS, COPACK 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER



D²Pak (TO-263AB) Part Marking Information

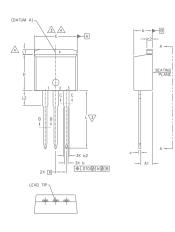


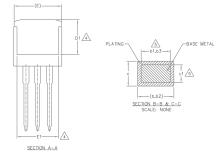
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



AUIRF4905S/L

TO-262 Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs.	CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

HEXFET DIODES

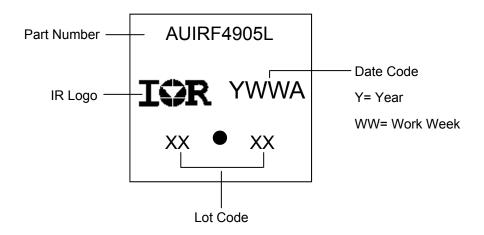
- 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE
- 1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN





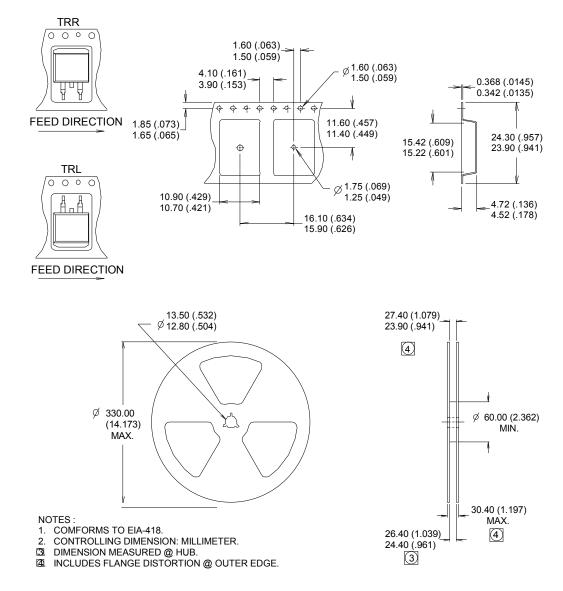
S Y M		N			
B	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
A	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	-	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2.54	2.54 BSC		BSC	
L	13.46	14.10	.530	.555	
L1	-	1.65	-	.065	4
L2	3.56	3.71	.140	.146	

TO-262 Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)					
Qualificatio	on Level		Comments: This part number(s) passed Automotive qualification. Infineon' ndustrial and Consumer qualification level is granted by extension of the highe Automotive level.				
Moisture Sensitivity Level		TO-262 Pak	MOL 4				
		D ² -Pak	MSL1				
	Machine Model	Class M4 (+/- 425V) [†]					
		AEC-Q101-002					
	Human Dady Madal	Class H2 (+/- 4000V) [†]					
ESD	ESD Human Body Model		AEC-Q101-001				
Objective di Districte Mandal		Class C5 (+/- 1125V) [†]					
	Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes					

† Highest passing voltage.

Revision History

Date	Comments
11/13/2015	Updated datasheet with corporate template
	Corrected ordering table on page 1.

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